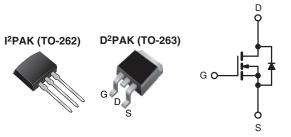




### Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	900				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 8.0				
Q <sub>g</sub> (Max.) (nC)	38				
Q <sub>gs</sub> (nC)	4.7				
Q <sub>gd</sub> (nC)	21				
Configuration	Single				

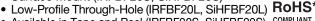


# N-Channel MOSFET

#### **FEATURES**

 Halogen-free According to IEC 61249-2-21 Definition





• Available in Tape and Reel (IRFBF20S, SiHFBF20S) COMPLIANT

• Dynamic dV/dt Rating

150 °C Operating Temperature

Fast Switching

Fully Avalanche Rated

Compliant to RoHS Directive 2002/95/EC

### **HALOGEN** FREE

### **DESCRIPTION**

Third generation Power MOSFETs form Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D<sup>2</sup>PAK is a surface mount power package capabel of the accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D<sup>2</sup>PAK is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application. The through-hole version (IRFBF20L, SiHFBF20L) is available for low-profile applications.

ORDERING INFORMATION						
Package	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	I <sup>2</sup> PAK (TO-262)		
Lead (Pb)-free and Halogen-free	SiHFBF20S-GE3	SiHFBF20STRL-GE3a	SiHFBF20STRR-GE3a	SiHFBF20L-GE3		
Lead (Pb)-free	IRFBF20SPbF	IRFBF20STRLPbFa	IRFBF20STRRPbFa	IRFBF20LPbF		
	SiHFBF20S-E3	SiHFBF20STL-E3a	SiHFBF20STR-E3a	SiHFBF20L-E3		
SnPb	IRFBF20S	IRFBF20STRL <sup>a</sup>	IRFBF20STRR <sup>a</sup>	IRFBF20L		
OH D	SiHFBF20S-E3	SiHFBF20STL <sup>a</sup>	SiHFBF20STR <sup>a</sup>	SiHFBF20L		

Note
a. See device orientation.

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltagee			$V_{DS}$	900	V		
Gate-Source Voltage <sup>e</sup>			V <sub>GS</sub>	± 20	]		
Continuous Drain Current	\/ at 10\/	T <sub>C</sub> = 25 °C	l <sub>D</sub>	1.7			
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		1.1	Α		
Pulsed Drain Current <sup>a,e</sup>	I <sub>DM</sub>	6.8	1				
Linear Derating Factor				0.43	W/°C		
Single Pulse Avalanche Energy <sup>b, e</sup>			E <sub>AS</sub>	180	mJ		
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	1.7	А		
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	5.4	mJ		
Maximum Dawar Dissipation	T <sub>C</sub> = 25 °C		D	54	W		
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		$P_D$	3.1			
Peak Diode Recovery dV/dtc, e			dV/dt	1.5	V/ns		
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	- °C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>			
Mounting Torque	6-32 or I	M3 screw		10	N		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 ^{\circ}\text{C}$ , L = 117 mH,  $R_g = 25 ^{\circ}\Omega$ ,  $I_{AS} = 1.7 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 1.7 \text{ A}$ ,  $I_{AS} = 1.7 \text{ A}$ , I

- Uses IRFBF20, SiHFBF20 data and test conditions.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFBF20S, SiHFBF20S, IRFBF20L, SiHFBF20L

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient (PCB Mounted, steady-state) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W		
Maximum Junction-to-Case	$R_{thJC}$	-	2.3			

### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static		<del>-</del>			•	•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 250 μA	900	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	1.1	-	mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V	
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 100	nA	
Zara Cata Valtaga Prain Current		V <sub>DS</sub> =	V <sub>DS</sub> = 900 V, V <sub>GS</sub> = 0 V		-	100	μА	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 720 V	V <sub>DS</sub> = 720 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	500		
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 1.0 A <sup>b</sup>	-	-	8.0	Ω	
Forward Transconductance	9fs	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 1.0 A <sup>b</sup>		0.6	-	-	S	
Dynamic								
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$		-	490	-	pF	
Output Capacitance	C <sub>oss</sub>	]	$V_{DS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0  MHz,  see fig. 5		55	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	] f = 1			18	-		
Total Gate Charge	Qg			-	-	38		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 1.7 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and $13^b$	-	-	4.7	nC	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	21		
Turn-On Delay Time	t <sub>d(on)</sub>			-	8.0	-		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 450 V, $I_D$ = 1.7 A, $R_g$ = 18 $\Omega$ , $V_{GS}$ = 10 V, see fig. 10 <sup>b</sup>		-	21	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	56	-		
Fall Time	t <sub>f</sub>			-	32	-		

SPECIFICATIONS (T <sub>J</sub> = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the	-	ı	1.7	Α	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode	-	-	6.8	A	
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C}, \ I_S = 1.7  \text{A}, \ V_{GS} = 0  \text{V}^{\text{b}}$	-	-	1.5	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 ^{\circ}\text{C}, I_F = 1.7 \text{A},  \text{dI/dt} = 100 \text{A/}\mu\text{s}^b$	-	350	530	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$I_1 = 25$ C, $I_F = 1.7$ A, $I_{A}$ and $I_{A} = 100$ A/ $\mu$ S	-	0.85	1.3	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )				L <sub>D</sub> )	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.
- c. Uses IRFBF20/SiHFBF20 data and test conditions.

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

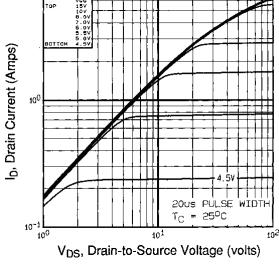
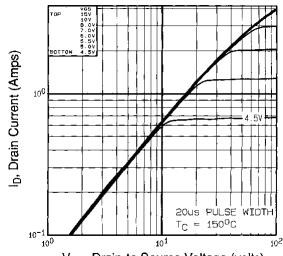


Fig. 1 - Typical Output Characteristics



V<sub>DS</sub>, Drain-to-Source Voltage (volts) Fig. 2 - Typical Output Characteristics

## IRFBF20S, SiHFBF20S, IRFBF20L, SiHFBF20L

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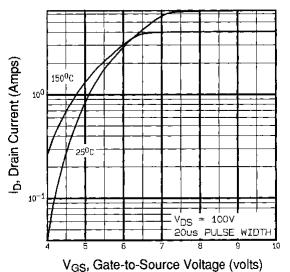


Fig. 3 - Typical Transfer Characteristics

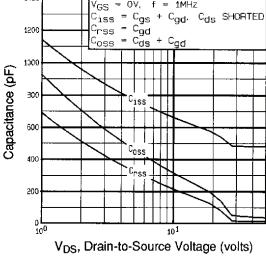


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

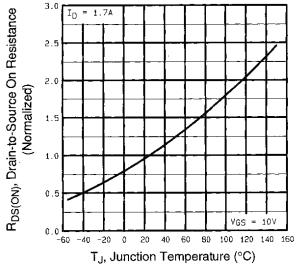


Fig. 4 - Normalized On-Resistance vs. Temperature

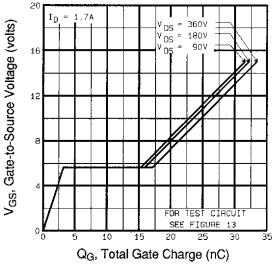


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

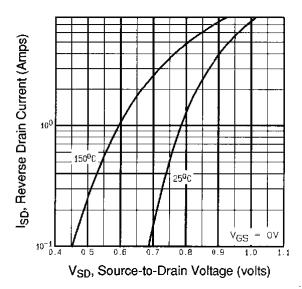


Fig. 7 - Typical Source-Drain Diode Forward Voltage

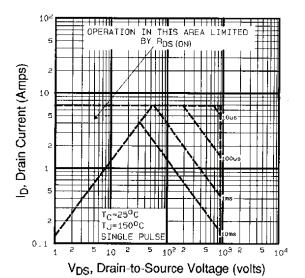


Fig. 8 - Maximum Safe Operating Area

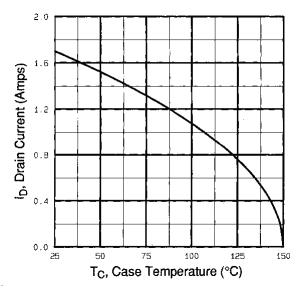


Fig. 9 - Maximum Drain Current vs. Case Temperature

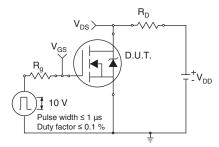


Fig. 10a - Switching Time Test Circuit

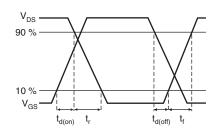


Fig. 10b - Switching Time Waveforms



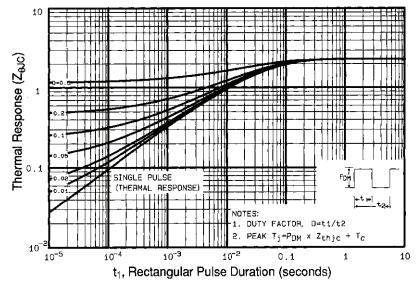


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

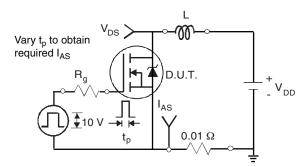


Fig. 12a - Unclamped Inductive Test Circuit

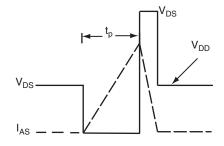


Fig. 12b - Unclamped Inductive Waveforms

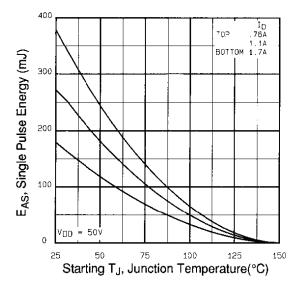


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

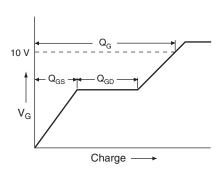


Fig. 13a - Basic Gate Charge Waveform

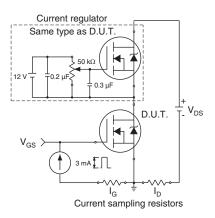


Fig. 13b - Gate Charge Test Circuit

## 

Peak Diode Recovery dV/dt Test Circuit

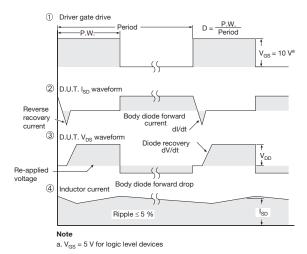


Fig. 14 - For N-Channel

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